LITEON®
OPTOELECTRONICS

Through Hole Lamp
Product Data Sheet
LTL-R42NM01H106P

Spec No. :DS20-2019-0009
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Revision: A

LITE-ON DCC

RELEASE

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Rev	Description	By	Date
P01	Preliminary New Specification (RDR-20171722-01)	Javy H.	3/15/2018
P02	Update Packing Quantity	Chalerm Ya.	1/21/2019
Above data for PD and Customer tracking only			
-	New Specification Upload On OPNC	Chalerm Ya.	1/22/2019
A	Update packing spec	Perry W / Chalerm Ya	12/15/2022

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1. Description

CBI (Circuit Board Indicator) is a black plastic right angle Holder (Housing) which mates with Lite-On LED lamps. Lite-On CBI is available in a wide variety of packages, including top-view (Spacer) or right angle and horizontal or vertical arrays which is stackable and easy to assembly.

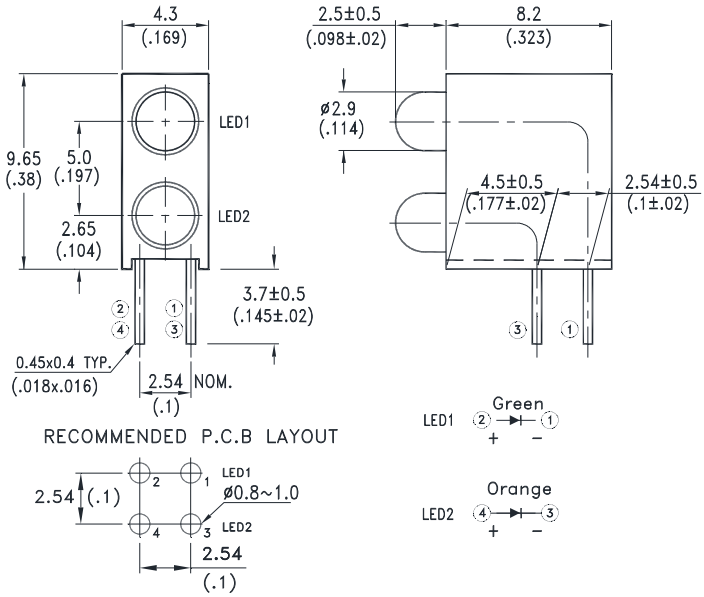
1. 1. Features

- Designed for ease in circuit board assembly.
- Black case enhance contrast ratio.
- Solid state light source.
- Low power consumption & High efficiency.
- Lead free product & RoHS Compliant.
- T-1 lamp : emitted source are 605nm yellow color and 569nm green color.

1.2. Applications

- Computer
- Communication
- Consumer
- Industrial

2. Outline Dimensions



Notes :

1. All dimensions are in millimeters (inches).
2. Tolerance is ±0.25mm (.010") unless otherwise noted.
3. The Holder (Housing) material is plastic black.
4. LED1 is green (yellow green) color with green diffused Lens; LED2 is orange color with amber diffused Lens.
5. Specifications are subject to change without notice.

3. Absolute Maximum Ratings at TA=25℃

Parameter	Green (Yellow green)	Orange	Unit
Power Dissipation	120	72	mW
Peak Forward Current (Duty Cycle≦1/10, Pulse Width≦10ms)	90	60	mA
DC Forward Current	30	20	mA
Derating Linear From 30℃	0.57	0.27	mA/℃
Operating Temperature Range	-40℃ to + 85℃		
Storage Temperature Range	-40℃ to + 100℃		
Lead Soldering Temperature [2.0mm (.079") From Body]	260℃ for 5 Seconds Max.		

4. Electrical / Optical Characteristics at TA=25℃

Parameter	Symbol	Color	Min.	Typ.	Max.	Unit	Test Condition
Luminous Intensity	IV	Green	8.7	19	50	mcd	IF=10mA Note 1,4
		Orange	30	65	140		
Viewing Angle	2θ1/2	Green		100		deg	Note 2 (Fig.6)
		Orange		100			
Peak Emission Wavelength	λP	Green		572		nm	Measurement @Peak (Fig.1)
		Orange		586			
Dominant Wavelength	λd	Green	566	569	574	nm	IF=10 mA, Note 3
		Orange	598	606	613.5		
Spectral Line Half-Width	Δλ	Green		15		nm	
		Orange		17			
Forward Voltage	VF	Green		2.0	2.5	V	IF=10mA
		Orange		1.9	2.5		
Reverse Current	IR	Green			100	μA	VR = 5V, Note 6
		Orange					

NOTE:

1. Luminous intensity is measured with a light sensor and filter combination that approximates the CIE eye-response curve.
2. θ1/2 is the off-axis angle at which the luminous intensity is half the axial luminous intensity.
3. The dominant wavelength, λd is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.
4. Iv guarantee must be included with ±15% testing tolerance.
5. Reverse current is controlled by dice source.
6. Reverse voltage (VR) condition is applied for IR test only. The device is not designed for reverse operation.

5. Typical Electrical / Optical Characteristics Curves

(25℃ Ambient Temperature Unless Otherwise Noted)

(Green color)

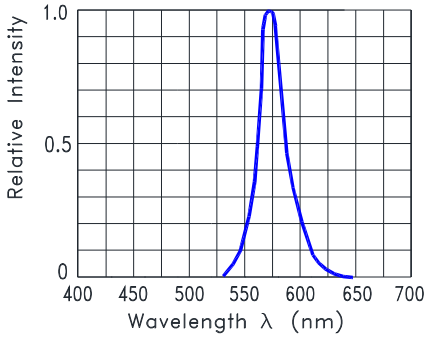


Fig.1 Relative Intensity VS.

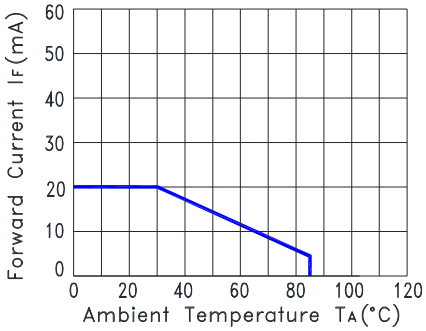


Fig.2 Forward Current Derating Curve

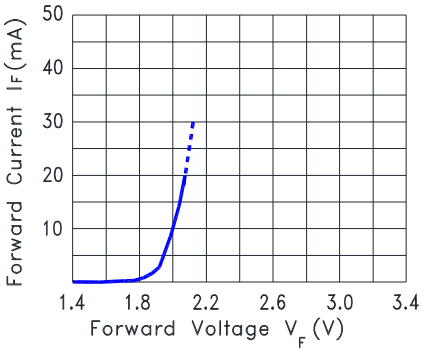


Fig.3 Forward Current vs. Forward Voltage

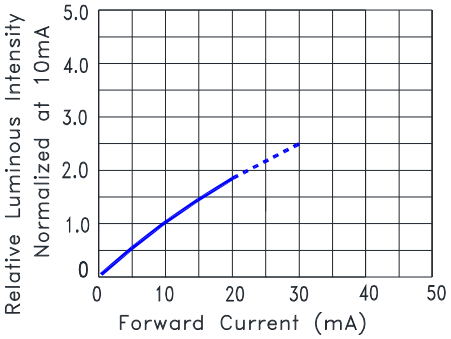


Fig.4 Relative Luminous Intensity vs. Forward Current

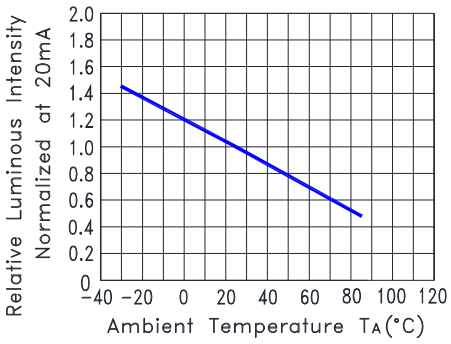


Fig.5 Relative Luminous Intensity VS. Ambient Temperature

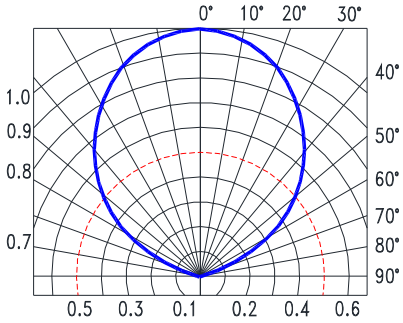


Fig.6 Spatial Distribution

(Orange color)

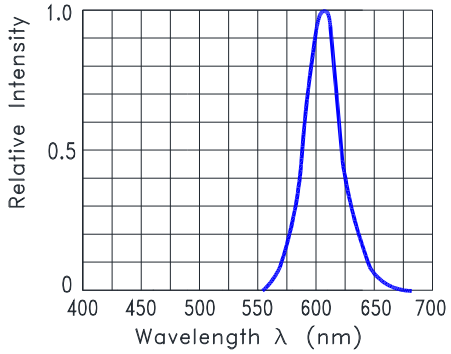


Fig.1 Relative Intensity VS. Wavelength

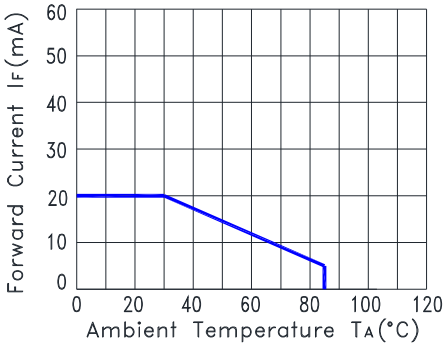


Fig.2 Forward Current Derating Curve

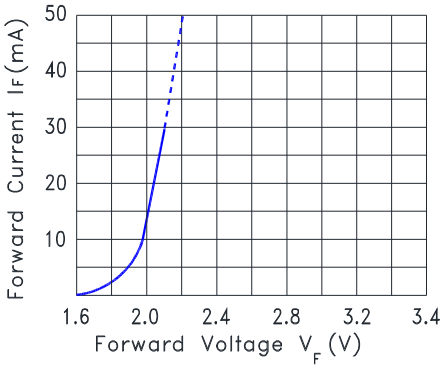


Fig.3 Forward Current vs. Forward Voltage

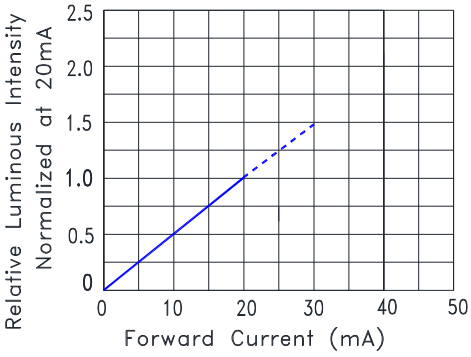


Fig.4 Relative Luminous Intensity vs. Forward Current

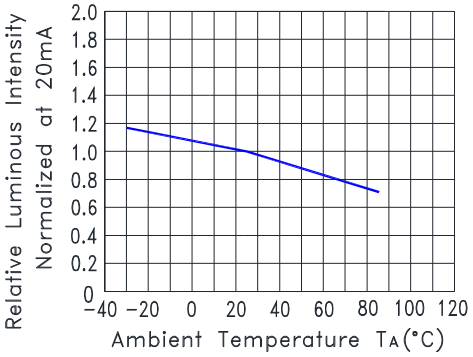


Fig.5 Relative Luminous Intensity VS. Ambient Temperature

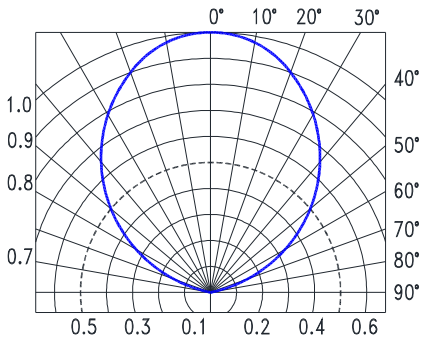
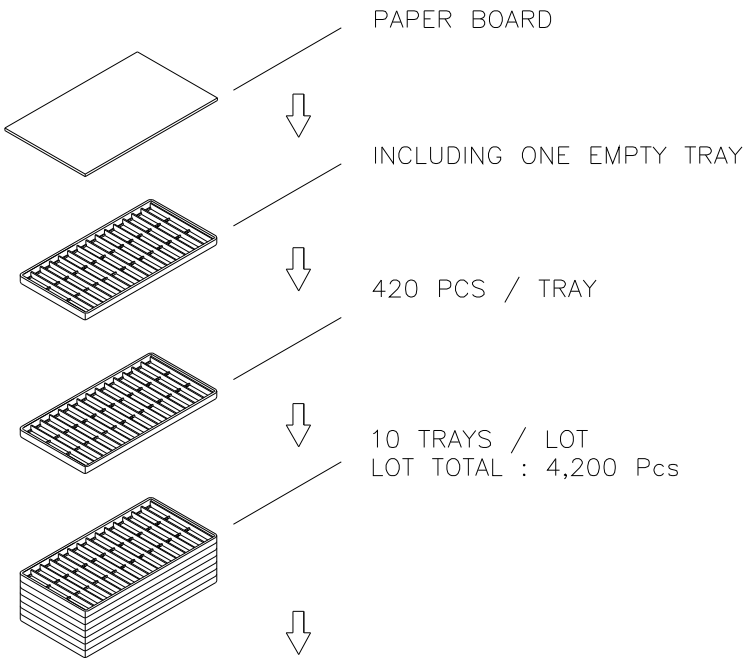
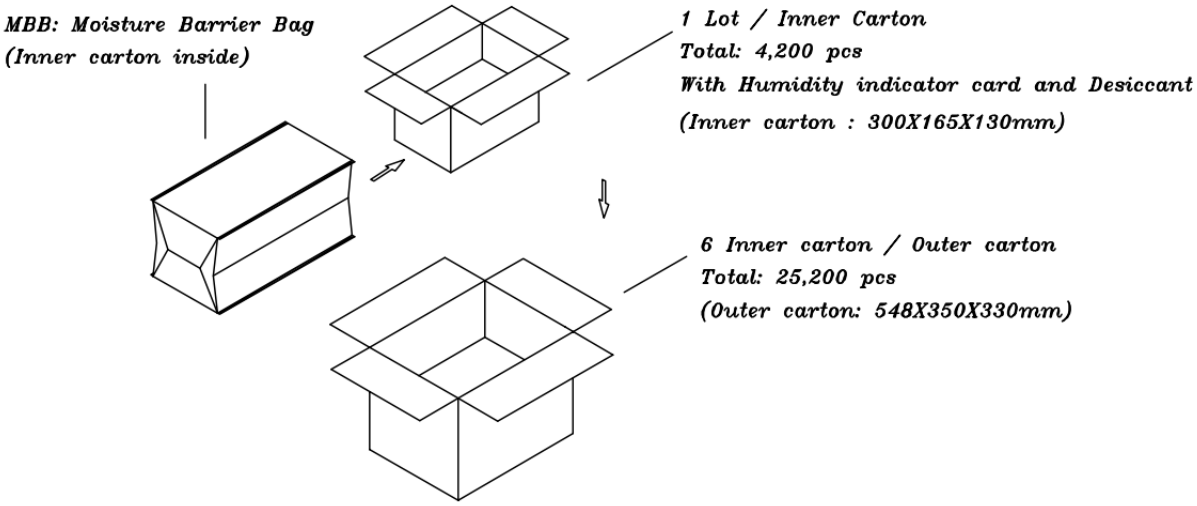


Fig.6 Spatial Distribution

6. Packing Specification





7. Bin Table Specification

Bin Table Specification (Yellow green)

Luminous Intensity, Unit: mcd, IF=10mA		
Iv Bin Code	**Min.**	**Max.**
L3	8.7	12.6
L2	12.6	19
L1	19	29
M1	29	50

Note: Tolerance of each bin limit is ±15%

Dominant Wavelength, Unit: nm, IF=10mA		
Hue Bin Code	**Min.**	**Max.**
H06	566.0	568.0
H07	568.0	570.0
H08	570.0	572.0
H09	572.0	574.0

Note: Tolerance of each bin limit is ±1nm

Bin Table Specification (Orange)

Luminous Intensity, Unit: mcd, IF=10mA		
Iv Bin Code	**Min.**	**Max.**
AB	30	50
CD	50	85
EF	85	140

Note: Tolerance of each bin limit is ±15%

Dominant Wavelength, Unit: nm, IF=10mA		
Hue Bin Code	**Min.**	**Max.**
H22	598.0	600.0
H23	600.0	603.0
H24	603.0	606.5
H25	606.5	610.0
H26	610.0	613.5

Note: Tolerance of each bin limit is ±1nm

8. CAUTIONS

8.1. Application

This LED lamp is good for application of indoor and outdoor sign, also ordinary electronic equipment.

8.2. Storage

The storage ambient for the LEDs should not exceed 30℃ temperature or 70% relative humidity. It is re commended that LEDs out of their original packaging are used within three months. For extended storage out of their original packaging, it is recommended that the LEDs be stored in a sealed container with appropriate desiccant or in desiccators with nitrogen ambient.

8.3. Cleaning

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LEDs if necessary.

8.4. Lead Forming & Assembly

During lead forming, the leads should be bent at a point at least 3mm from the base of LED lens. Do not use the base of the lead frame as a fulcrum during forming. Lead forming must be done before soldering, at normal temperature. During assembly on PCB, use minimum clinch force possible to avoid excessive mechanical stress.

8.5. Soldering

When soldering, leave a minimum of 2mm clearance from the base of the lens/Holder to the soldering point. Dipping the lens/Holder into the solder must be avoided. Do not apply any external stress to the lead frame during soldering while the LED is at high temperature.

Recommended soldering conditions:

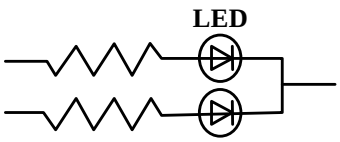
Soldering iron		Wave soldering	
Temperature Soldering time Position	350℃ Max. 3 seconds Max. (one time only) No closer than 2mm from the base of the epoxy bulb	Pre-heat Pre-heat time Solder wave Soldering time Dipping Position	120℃ Max. 100 seconds Max. 260℃ Max. 5 seconds Max. No lower than 2mm from the base of the epoxy bulb

Note: Excessive soldering temperature and/or time might result in deformation of the LED lens or catastrophic failure of the LED.

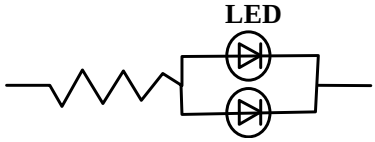
8.6. Drive Method

An LED is a current-operated device. In order to ensure intensity uniformity on multiple LEDs connected in parallel in an application, it is recommended that a current limiting resistor be incorporated in the drive circuit, in series with each LED as shown in Circuit A below.

Circuit model (A)



Circuit model (B)



(A) Recommended circuit
(B) The brightness of each LED might appear different due to the differences in the I-V characteristics of those LEDs.

8.7. ESD (Electrostatic Discharge)

Static Electricity or power surge will damage the LED.

Suggestions to prevent ESD damage:

- Use a conductive wrist band or anti- electrostatic glove when handling these LEDs
- All devices, equipment, and machinery must be properly grounded
- Work tables, storage racks, etc. should be properly grounded
- Use ion blower to neutralize the static charge which might have built up on surface of the LEDs plastic lens as a result of friction between LEDs during storage and handing

Suggested checking list:

Training and Certification

8.7.1.1. Everyone working in a static-safe area is ESD-certified?
8.7.1.2. Training records kept and re-certification dates monitored?

Static-Safe Workstation & Work Areas

8.7.2.1. Static-safe workstation or work-areas have ESD signs?
8.7.2.2. All surfaces and objects at all static-safe workstation and within 1 ft measure less than 100V?
8.7.2.3. All ionizer activated, positioned towards the units?
8.7.2.4. Each work surface mats grounding is good?

Personnel Grounding

8.7.3.1. Every person (including visitors) handling ESD sensitive (ESDS) items wear wrist strap, heel strap or conductive shoes with conductive flooring?
8.7.3.1. If conductive footwear used, conductive flooring also present where operator stand or walk?
8.7.3.2. Garments, hairs or anything closer than 1 ft to ESD items measure less than 100V*?
8.7.3.3. Every wrist strap or heel strap/conductive shoes checked daily and result recorded for all DLs?
8.7.3.4. All wrist strap or heel strap checkers calibration up to date?
Note: *50V for Blue LED.

Device Handling

8.7.4.1. Every ESDS items identified by EIA-471 labels on item or packaging?
8.7.4.2. All ESDS items completely inside properly closed static-shielding containers when not at static-safe workstation?
8.7.4.3. No static charge generators (e.g. plastics) inside shielding containers with ESDS items?
8.7.4.4. All flexible conductive and dissipative package materials inspected before reuse or recycle?

Others

8.7.5.1. Audit result reported to entity ESD control coordinator?
8.7.5.2. Corrective action from previous audits completed?
8.7.5.3. Are audit records complete and on file?

9. Reliability Test

Classification	Test Item	Test Condition	Sample Size	Reference Standard
Endurance Test	Operation Life	Ta = Under Room Temperature IF= Per Data Sheet Maximum Rating Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1026 (1995) MIL-STD-883G:1005 (2006)
	High Temperature High Humidity storage (THB)	Ta = 60℃ RH = 90% Test Time= 240hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-202G:103B (2002) JEITA ED-4701:100 103 (2001)
	High Temperature Storage	Ta= 105 ± 5℃ Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1031 (1995) MIL-STD-883G:1008 (2006) JEITA ED-4701:200 201 (2001)
	Low Temperature Storage	Ta= -55 ± 5℃ Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	JEITA ED-4701:200 202 (2001)
Environmental Test	Temperature Cycling	100℃ ～ 25℃ ～ -40℃ ～ 25℃ 30mins 5mins 30mins 5mins Test time: 30 Cycles	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1051 (1995) MIL-STD-883G:1010 (2006) JEITA ED-4701:100 105 (2001) JESD22-A104C (2005)
	Thermal Shock	100 ± 5℃ ～ -30℃ ± 5℃ 15mins 15mins Test time: 30 Cycles	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1056 (1995) MIL-STD-883G:1011 (2006) MIL-STD-202G:107G (2002) JESD22-A106B (2004)
	Solder Resistance	T.sol = 260 ± 5℃ Dwell Time= 10±1 seconds 3mm from the base of the epoxy bulb	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-750D:2031(1995) JEITA ED-4701: 300 302 (2001)
	Solderability	T. sol = 245 ± 5℃ Dwell Time= 5 ± 0.5 seconds (Lead Free Solder, Coverage ≧95% of the dipped surface)	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-750D:2026 (1995) MIL-STD-883G:2003 (2006) MIL-STD-202G:208H (2002) IPC/EIA J-STD-002 (2004)
	Soldering Iron	T. sol = 350 ± 5℃ Dwell Time= 3.5 ± 0.5 seconds	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-202G:208H (2002) JEITA ED-4701:300 302 (2001)

10. Others

The appearance and specifications of the product may be modified for improvement, without prior notice.